OPTICAL BEAM MEASUREMENT OPTICS / NFP&FFP SIMULTANEOUS MEASUREMENT & ANALYSIS

NFP/FFP SIMULTANEOUS MEASUREMENT OPTICS M-Scope type D

Realize simultaneous observation and analysis of NFP and FFP by single optical unit.

M-Scope type D realizes simultaneous observation and analysis of NFP and FFP by a single optical unit. M-Scope type D has NFP measurement port and FFP measurement port in single optical base, and no need to switch the optics during each measurement.

[Features]

OSimultaneous analysis of NFP and FFP by a single optical unit.

OSpecially designed optics for real-time observation and analsis of NFP/FFP

OLong working distance of approx. 17mm when measuring FFP

OPossible to measure in 400nm to 1700nm wavelength range by selecting detector. OHigh-performance NFP/FFP simultaneous measurement system can be constructed by using Synos' optical beam analysis module AP013 together.

[Summary of specifications]

ONFP/FFP measurement common specifications

- M-Plan Apo NIR 50x (fixed) • Objective lens: 17mm
- W.D.:
- Objective lens change: By manual revolver
- * Objective lenses with various magnifications can be used only during NFP measurement
- ONFP measurement port
 - Intermediate lens:
 - $1 \times$ • Maximum optical magnification: 50×
 - Epi-illumination: Option
 - Attenuate: By neutral density filter
 - Camera mount: C mount
- ○FFP measurement port
 - Measurement spectral range

Please specify the measurement wavelength because appropriate AR coating is required for optical path splitting half mirror of NFP/FFP port.

- Attenuate: By neutral density filter
- Camera mount: C mount

(Available detectors selection)

Ofor 400~1100nm: Hi-resolution CMOS detector ISA071, ISA071GL ○for 950~1700nm: InGaAs NIR detector ISA041H2 Ofor 400~1700nm: InGaAs NIR derector ISA041HRA Transported and pixel resolution during NFP measurement

and the measurement angle coverage and pixel resolution during FFP measurement by the detector used, please refer to P50 [Detector selection and NFP/FFP simultaneous measurement specifications



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[Standard component]

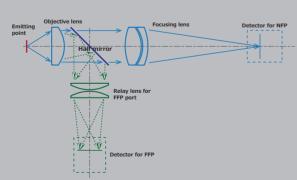
OMain optics: 1 Optics base: 1

[Option]

Option for **M-Scope type D** optics

- •2× intermediate lens port MS-OP011-RL2 Intermediate lens unit that doubles the overall magnification of the optical system. (up to $100 \times$ with $50 \times$ objective lens)
- •1/2× intermediate lens port MS-OP011-RLH Intermediate lens unit that halves the overall magnification of the optical system.
- Coaxial epi-illumination port MS-OP011-CEP Coaxial epi-illumination port with removable half mirror. OAccessories for optics
 - Objective lens, ND filter, coaxial epi- illumination light source, optics bench, etc.

Technical Information [Principle of NFP/FFP simultaneous measurement]



In M-Scope type D, FFP is measured using objective lens. In the figure on the left, the luminous flux emitted from the emitting point is incident on the objective lens and then the optical path is split by the half mirror. The light flux that has passed through the half mirror advances to the NFP port side and is imaged on the NFP measurement detector via the focusing lens. On the other hand, the light flux reflected by the half mirror advances to the FFP port side and is imaged on the FFP measurement detector via the FFP relay lens. In this way, NFP and FFP images obtained from each port branched into two optical paths are analyzed by image processing, and NFP/FFP measurement are realized with a single optical unit. Since this optics uses objective lens to measure NFP/FFP, the diameter of the light flux to be measured is very narrow (about 100 µm), it is necessary to adjust the position and focus on the NFP image. Additionally, the measurement wavelength is limited because appropriate AR coating is required for optical path splitting half mirror of NFP/FFP port. These are major differences from the FFP measurement method using f-0 lens.

[Differences in methods and advantages and disadvantages of optical method FFP measurement]

Meas. Method	Optics	Advantage	Disadvantage
f -θ lens method	M-Scope type F	OBasic method of FFP analysis by optics	• Cannot observe real image
	M-Scope type FW	ONo need for strict focus adjustment	 Short W.D. of approx. 6mm
	etc.	OWide angle coverage of approx. ±40 °	 Possible to secure wide measurement spectral range
Objective lens	M-Scope type D	OEnables NFP/FFP analysis in single optics	 Strict focus & position adjustment is required
method		OCan observe real image by NFP image	 Nallow angle coverage of approx. ±24.5°
		OLong W.D. of approx. 17mm	 Accuracy on the wide-angle side deteriorates
			• Measurement wavelength is limited due to the use of
			HM. Affected by interference due to half mirror.